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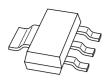
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Kind regards,

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# $\begin{array}{c} \textbf{PBSS303PZ} \\ \textbf{30 V, 5.3 A PNP low V}_{\textbf{CEsat}} \text{ (BISS) transistor} \\ \hline \textbf{Rev. 02-20 November 2009} \end{array}$

Product data sheet

# **Product profile**

#### 1.1 General description

PNP low V<sub>CEsat</sub> Breakthrough In Small Signal (BISS) transistor in a SOT223 (SC-73) small Surface-Mounted Device (SMD) plastic package.

NPN complement: PBSS303NZ.

## 1.2 Features

- Low collector-emitter saturation voltage V<sub>CEsat</sub>
- High collector current capability I<sub>C</sub> and I<sub>CM</sub>
- High collector current gain (h<sub>FE</sub>) at high I<sub>C</sub>
- High efficiency due to less heat generation
- Smaller required Printed-Circuit Board (PCB) area than for conventional transistors

## 1.3 Applications

- DC-to-DC conversion
- MOSFET gate driving
- Motor control
- Charging circuits
- Power switches (e.g. motors, fans)

#### 1.4 Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$V_{\text{CEO}}$	collector-emitter voltage	open base	-	-	-30	V
Ic	collector current		-	-	-5.3	А
I <sub>CM</sub>	peak collector current	single pulse; $t_p \le 1 \text{ ms}$	-	-	-10.6	Α
R <sub>CEsat</sub>	collector-emitter saturation resistance	$I_C = -4 \text{ A};$ $I_B = -200 \text{ mA}$	<u>[1]</u> -	36	53	mΩ

[1] Pulse test:  $t_p \le 300 \ \mu s; \ \delta \le 0.02.$ 



#### **Pinning information** 2.

Table 2. **Pinning** 

	9		
Pin	Description	Simplified outline	Symbol
1	base		
2	collector	4	2, 4
3	emitter		1—
4	collector	1 -2 -3	. ,
			3
			sym028

#### **Ordering information** 3.

Table 3. **Ordering information** 

Type number	Package					
	Name	Description	Version			
PBSS303PZ	SC-73	plastic surface-mounted package with increased heat sink; 4 leads	SOT223			

# **Marking**

**Product data sheet** 

Table 4. **Marking codes** 

Type number	Marking code
PBSS303PZ	S303PZ

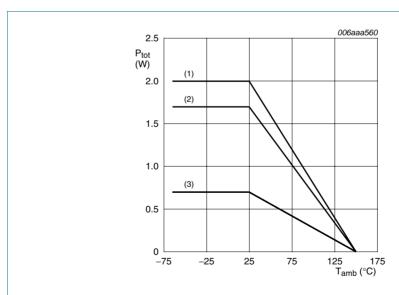
# 5. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

		0 , ,	,		
Symbol	Parameter	Conditions	Min	Max	Unit
$V_{CBO}$	collector-base voltage	open emitter	-	-30	V
$V_{CEO}$	collector-emitter voltage	open base	-	-30	V
$V_{EBO}$	emitter-base voltage	open collector	-	-5	V
Ic	collector current		-	-5.3	Α
I <sub>CM</sub>	peak collector current	single pulse; $t_p \le 1 \text{ ms}$	-	-10.6	Α
P <sub>tot</sub>	total power dissipation	$T_{amb} \leq 25~^{\circ}C$	[1] _	0.7	W
			[2] _	1.7	W
			[3]	2	W
Tj	junction temperature		-	150	°C
T <sub>amb</sub>	ambient temperature		-65	+150	°C
T <sub>stg</sub>	storage temperature		-65	+150	°C
-					

- [1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.
- [2] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 6 cm<sup>2</sup>.
- [3] Device mounted on a ceramic PCB, Al<sub>2</sub>O<sub>3</sub>, standard footprint.



- (1) Ceramic PCB, Al<sub>2</sub>O<sub>3</sub>, standard footprint
- (2) FR4 PCB, mounting pad for collector 6 cm<sup>2</sup>
- (3) FR4 PCB, standard footprint

Fig 1. Power derating curves

## 6. Thermal characteristics

Table 6. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{\text{th(j-a)}}$	thermal resistance from	in free air	<u>[1]</u> -	-	179	K/W
	junction to ambient		[2] _	-	74	K/W
			<u>[3]</u> _	-	63	K/W
$R_{th(j-sp)}$	thermal resistance from junction to solder point		-	-	15	K/W

- [1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.
- [2] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 6 cm<sup>2</sup>.
- [3] Device mounted on a ceramic PCB, Al<sub>2</sub>O<sub>3</sub>, standard footprint.

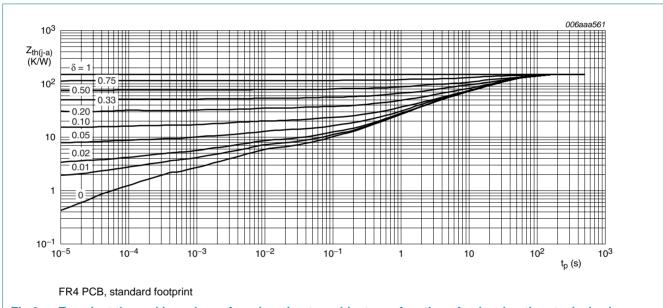


Fig 2. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values

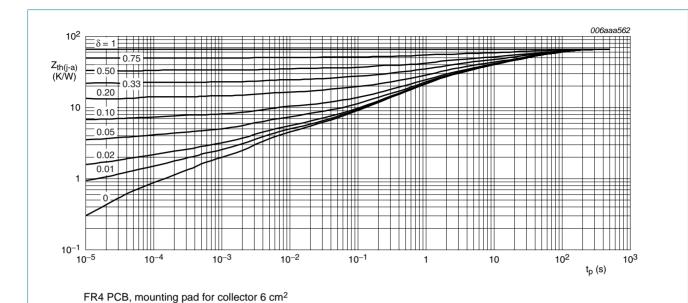


Fig 3. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values

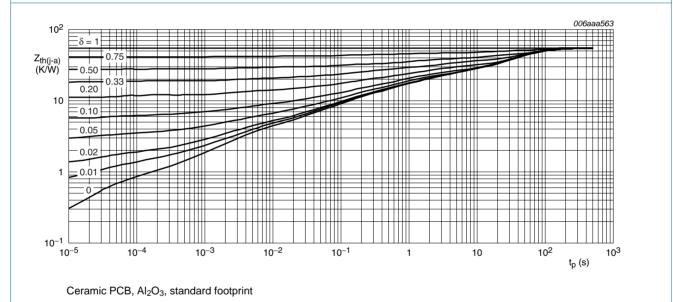


Fig 4. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values

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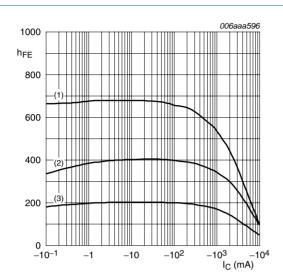
# 7. Characteristics

Table 7. Characteristics

 $T_{amb} = 25 \, ^{\circ}\text{C}$  unless otherwise specified.

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
I <sub>CBO</sub>		$V_{CB} = -30 \text{ V}; I_E = 0 \text{ A}$		-	-	-100	nA
	current	$V_{CB} = -30 \text{ V}; I_E = 0 \text{ A};$ $T_j = 150 \text{ °C}$		-	-	-50	μА
I <sub>EBO</sub>	emitter-base cut-off current	$V_{EB} = -5 \text{ V}; I_C = 0 \text{ A}$		-	-	-100	nA
h <sub>FE</sub>	DC current gain	$V_{CE} = -2 \text{ V}; I_{C} = -0.5 \text{ A}$	[1]	250	400	-	
		$V_{CE} = -2 \text{ V}; I_{C} = -1 \text{ A}$	[1]	250	350	-	
		$V_{CE} = -2 \text{ V}; I_{C} = -2 \text{ A}$	[1]	200	300	-	
		$V_{CE} = -2 \text{ V; } I_{C} = -4 \text{ A}$	[1]	130	200	-	
		$V_{CE} = -2 \text{ V; } I_{C} = -7 \text{ A}$	[1]	80	120	-	
$V_{CEsat}$	collector-emitter	$I_C = -0.5 \text{ A}; I_B = -50 \text{ mA}$	[1]	-	-25	-35	mV
	saturation voltage	$I_C = -1 \text{ A}; I_B = -50 \text{ mA}$	[1]	-	-50	-70	mV
		$I_C = -1 A$ ; $I_B = -10 \text{ mA}$	[1]	-	-75	-105	mV
		$I_C = -2 \text{ A}; I_B = -40 \text{ mA}$	[1]	-	-100	-140	mV
		$I_C = -4 \text{ A}; I_B = -200 \text{ mA}$	[1]	-	-145	-210	mV
		$I_C = -4 \text{ A}; I_B = -400 \text{ mA}$	[1]	-	-135	-190	mV
		$I_C = -4 \text{ A}; I_B = -40 \text{ mA}$	[1]	-	-245	-370	mV
		$I_C = -5.3 \text{ A}; I_B = -265 \text{ mA}$	[1]	-	-185	-265	mV
R <sub>CEsat</sub>	collector-emitter	$I_C = -4 \text{ A}; I_B = -200 \text{ mA}$	[1]	-	36	53	$m\Omega$
	saturation resistance	$I_C = -4 \text{ A}; I_B = -40 \text{ mA}$	[1]	-	61	92	$m\Omega$
√ <sub>BEsat</sub>	base-emitter	$I_C = -1 A$ ; $I_B = -100 \text{ mA}$	[1]	-	-0.82	-0.9	V
	saturation voltage	$I_C = -4 \text{ A}; I_B = -400 \text{ mA}$	[1]	-	-0.93	-1.05	V
$V_{BEon}$	base-emitter turn-on voltage	$V_{CE} = -2 \text{ V}; I_{C} = -2 \text{ A}$	[1]	-	-0.76	-0.85	V
d	delay time	$V_{CC} = -12.5 \text{ V}; I_C = -3 \text{ A};$		-	15	-	ns
r	rise time	$I_{Bon} = -0.15 \text{ A};$		-	55	-	ns
on	turn-on time	$I_{Boff} = 0.15 A$		-	70	-	ns
S	storage time			-	215	-	ns
f	fall time			-	105	-	ns
off	turn-off time			-	320	-	ns
ŤΤ	transition frequency	$V_{CE} = -10 \text{ V; } I_{C} = -100 \text{ mA;}$ f = 100 MHz		-	130	-	MHz
C <sub>c</sub>	collector capacitance	$V_{CB} = -10 \text{ V}; I_E = i_e = 0 \text{ A};$ f = 1 MHz		-	110	160	pF

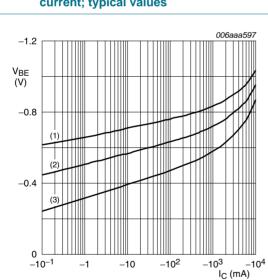
<sup>[1]</sup> Pulse test:  $t_p \le 300~\mu s;~\delta \le 0.02.$ 



$$V_{CE} = -2 V$$

- (1)  $T_{amb} = 100 \, ^{\circ}C$
- (2)  $T_{amb} = 25 \, ^{\circ}C$
- (3)  $T_{amb} = -55 \, ^{\circ}C$

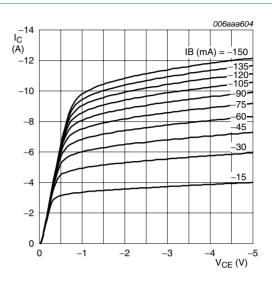
Fig 5. DC current gain as a function of collector current; typical values





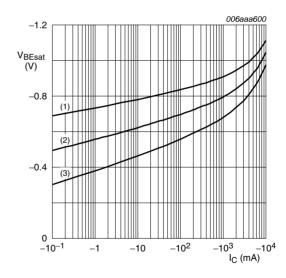
- (1)  $T_{amb} = -55 \, ^{\circ}C$
- (2)  $T_{amb} = 25 \, ^{\circ}C$
- (3)  $T_{amb} = 100 \, ^{\circ}C$

Fig 7. Base-emitter voltage as a function of collector current; typical values



T<sub>amb</sub> = 25 °C

Fig 6. Collector current as a function of collector-emitter voltage; typical values

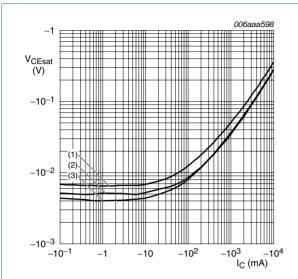


 $I_{\rm C}/I_{\rm B} = 20$ 

- (1)  $T_{amb} = -55 \, ^{\circ}C$
- (2)  $T_{amb} = 25 \, ^{\circ}C$
- (3)  $T_{amb} = 100 \, ^{\circ}C$

Fig 8. Base-emitter saturation voltage as a function of collector current; typical values

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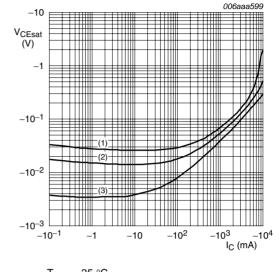
$$I_{\rm C}/I_{\rm B} = 20$$

(1) 
$$T_{amb} = 100 \, ^{\circ}C$$

(2) 
$$T_{amb} = 25 \, ^{\circ}C$$

(3) 
$$T_{amb} = -55 \, ^{\circ}C$$

Fig 9. Collector-emitter saturation voltage as a function of collector current; typical values



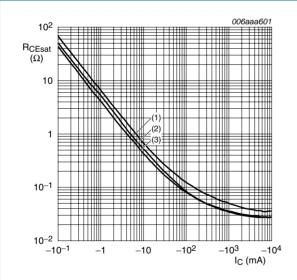
$$T_{amb} = 25 \, ^{\circ}C$$

(1) 
$$I_C/I_B = 100$$

(2) 
$$I_C/I_B = 50$$

(3) 
$$I_C/I_B = 10$$

Fig 10. Collector-emitter saturation voltage as a function of collector current; typical values



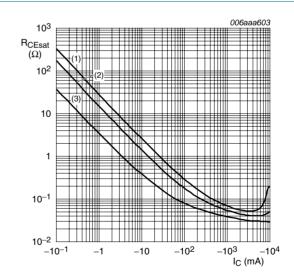
$$I_{\rm C}/I_{\rm B} = 20$$

(1) 
$$T_{amb} = 100 \, ^{\circ}C$$

(2) 
$$T_{amb} = 25 \, ^{\circ}C$$

(3) 
$$T_{amb} = -55 \, ^{\circ}C$$

Fig 11. Collector-emitter saturation resistance as a function of collector current; typical values



(1) 
$$I_C/I_B = 100$$

(2) 
$$I_C/I_B = 50$$

(3) 
$$I_C/I_B = 10$$

Fig 12. Collector-emitter saturation resistance as a function of collector current; typical values

# 8. Test information

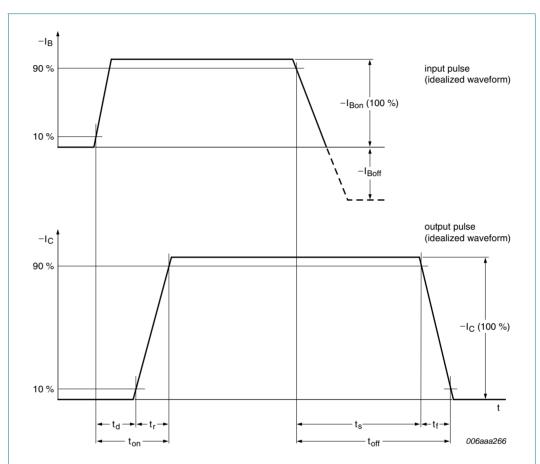
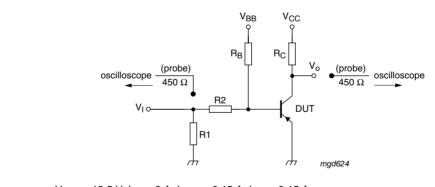


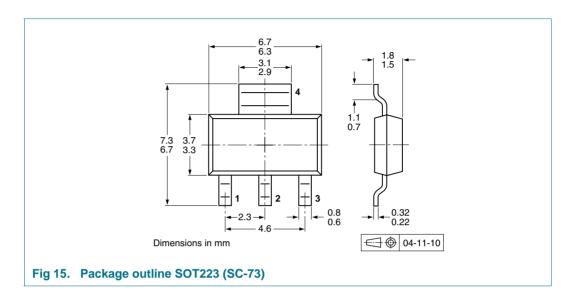
Fig 13. BISS transistor switching time definition



 $V_{CC} = -12.5 \text{ V}; I_C = -3 \text{ A}; I_{Bon} = -0.15 \text{ A}; I_{Boff} = 0.15 \text{ A}$ 

Fig 14. Test circuit for switching times

# 9. Package outline



# 10. Packing information

Table 8. Packing methods

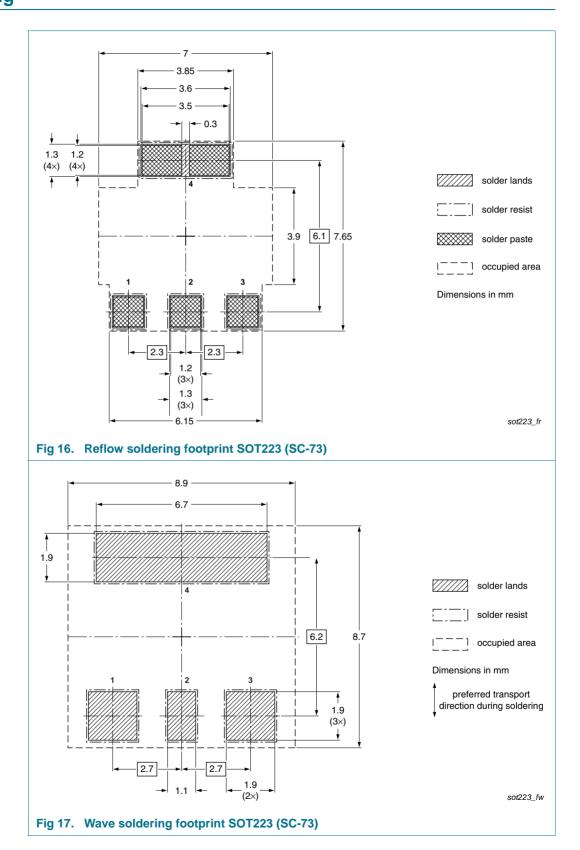
The indicated -xxx are the last three digits of the 12NC ordering code.[1]

Type number	Package	Description	Packing	quantity
			1000	4000
PBSS303PZ	SOT223	8 mm pitch, 12 mm tape and reel	-115	-135

[1] For further information and the availability of packing methods, see Section 14.

# 11. Soldering

**NXP Semiconductors** 



PBSS303PZ

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30 V, 5.3 A PNP low V<sub>CEsat</sub> (BISS) transistor

# 12. Revision history

#### Table 9. **Revision history**

**Product data sheet** 

	•			
Document ID	Release date	Data sheet status	Change notice	Supersedes
PBSS303PZ_2	20091120	Product data sheet	-	PBSS303PZ_1
Modifications:		eet was changed to reflect w legal definitions and disc		
	<ul><li>Figure 16 "R</li></ul>	eflow soldering footprint So	OT223 (SC-73)": updat	ted
	<ul><li>Figure 17 "W</li></ul>	lave soldering footprint SO	T223 (SC-73)": update	ed
PBSS303PZ_1	20060914	Product data sheet	-	-

PBSS303PZ

30 V, 5.3 A PNP low V<sub>CEsat</sub> (BISS) transistor

# 13. Legal information

#### Data sheet status 13.1

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

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**Product data sheet** 

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Date of release: 20 November 2009 Document identifier: PBSS303PZ\_2



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